Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/763,411	HANAI ET AL.	
Examiner	Art Unit	
Enrique L. Santiago	2671	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST SEARCH (USPAT, USPGPUBsee search history report)	3/16/2006	ELS	
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